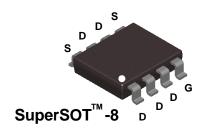
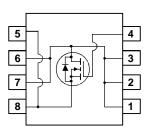
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Features

- 11.2 A, 20 V. $R_{DS(ON)} = 9 \ m\Omega @ V_{GS} = 4.5 \ V$ $R_{DS(ON)} = 11 \ m\Omega @ V_{GS} = 2.5 \ V$
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability in a smaller footprint than SO8





Absolute Maximum Ratings T_{A=25^oC unless otherwise noted}

Symbol	Parameter			Ratings	Units	
V _{DSS}	Drain-Sourc	e Voltage	20	V		
V _{GSS}	Gate-Source Voltage			±12		
I _D	Drain Current – Continuous (Note		(Note 1a)	11.2		
	– Pulsed			50		
P _D	Power Dissi	pation for Single Operation	(Note 1a)	1.8	W	
			(Note 1b)	1.0		
			(Note 1c)	0.9		
	Operating and Storage Junction Temperature Range			-55 to +150		
T _J , T _{STG}	Operating a	nd Storage Junction Tempe	erature Range	-55 to +150	°C	
Therma				-55 to +150 70		
	I Characi	teristics			2° W\2° W\2°	
Therma R _{θJA} R _{θJC} Packag Device	I Charact Thermal Re Thermal Re	teristics sistance, Junction-to-Ambie	ent (Note 1a) (Note 1)	70	°C/W	

FDR6580 Rev C(W)

FAIRCHILD

SEMICONDUCTOR®

FDR6580 N-Channel 2.5V Specified PowerTrench[®] MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{DS(ON)}$ in a small package.

Applications

- Synchronous rectifier
- DC/DC converter

Downloaded from Arrow.com.

FDR6580

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		11		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -12 \text{ V} , V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	0.5	0.9	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		-3.5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = 4.5 \ V, & I_D = 11.2 \ A \\ V_{GS} = 2.5 \ V, & I_D = 10.1 \ A \\ V_{GS} = 4.5 \ V, & I_D = 11.2 \ A, \ T_J \ 125^\circ C \end{array} $		5.2 6.6 7.1	9 11 13	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 4.5 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	25			Α
g fs	Forward Transconductance	$V_{DS} = 5 V$, $I_D = 11.2 A$		70		S
Dynamic	c Characteristics					
Ciss	Input Capacitance	$V_{DS} = 10 V$, $V_{GS} = 0 V$,		3829		pF
Coss	Output Capacitance	f = 1.0 MHz		854		pF
C _{rss}	Reverse Transfer Capacitance			446		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 10 V, \qquad I_D = 1 A,$		15	27	ns
tr	Turn–On Rise Time	$V_{GS} = 4.5 V, R_{GEN} = 6 \Omega$		20	32	ns
t _{d(off)}	Turn–Off Delay Time			62	99	ns
t _f	Turn–Off Fall Time			39	62	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, \qquad I_D = 11.2 \text{ A},$		34	48	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5V$		5.9		nC
Q _{gd}	Gate-Drain Charge			9.3		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain–Source Diode Forward Current				1.5	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 1.5 A$ (Note 2)		0.6	1.2	V

1. R_{6UA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 70°/W when mounted on a 1in² pad of 2 oz copper

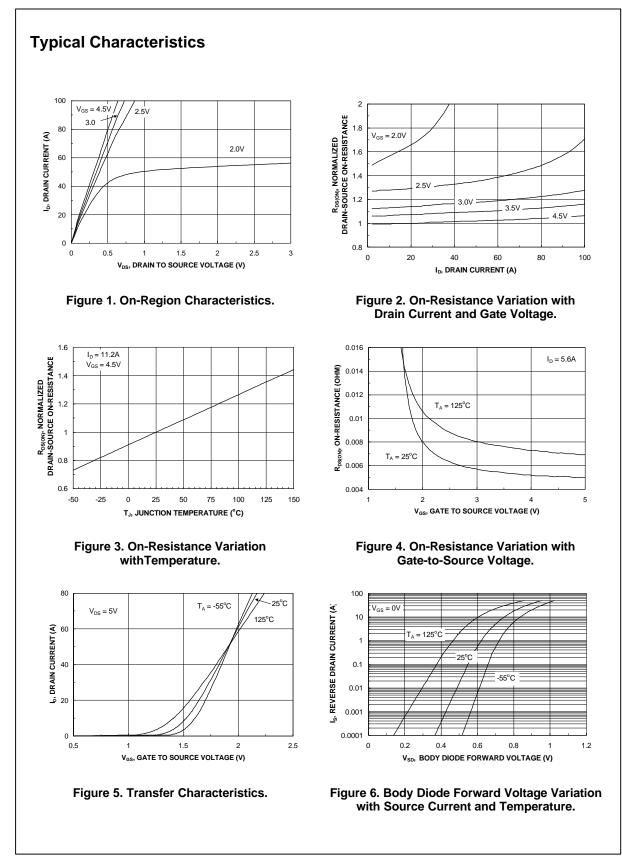


b) 125°/W when mounted on a .04 in² pad of 2 oz copper

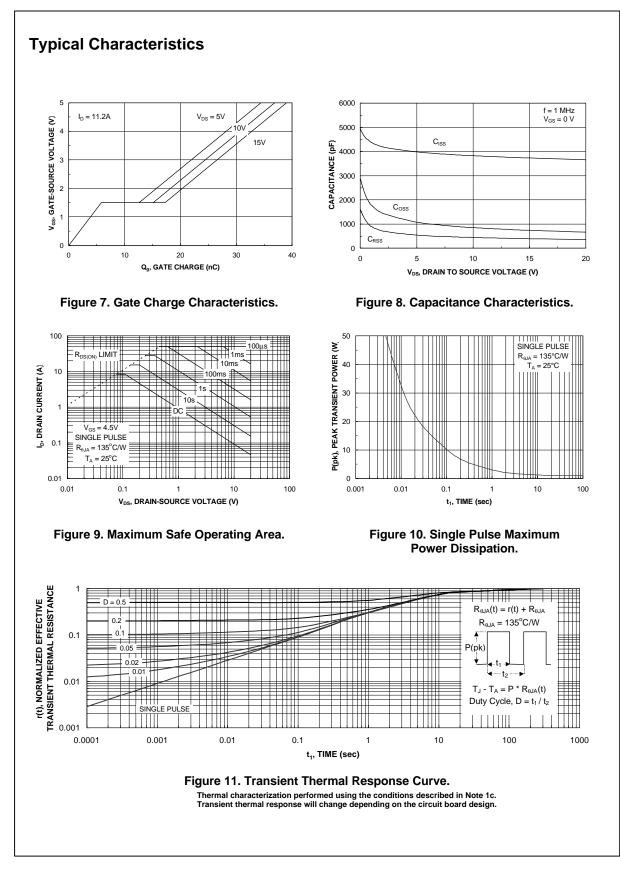
c) 135°/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%



FDR6580



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PRODUCT STATUS DEFINITIONS

Definition of Terms

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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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